

Automotive 750 V, 800 A **Dual Side Cooling Half-Bridge Power Module**

VE-Trac™ Dual NVG800A75L4DSC

Product Description

The NVG800A75L4DSC is part of a family of power modules with dual side cooling and compact footprints for Hybrid (HEV) and Electric Vehicle (EV) traction inverter application.

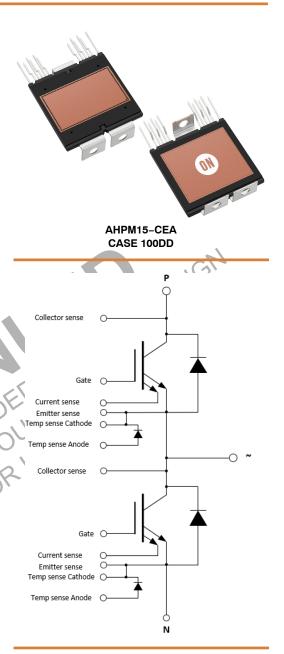
The module consists of two Field Stop 4 (FS4) 750 V Narrow Mesa IGBTs in a half-bridge configuration. The chipset utilizes the new narrow mesa IGBT technology in providing high current density and robust short circuit protection with higher blocking voltage to deliver outstanding performance in EV traction applications.

Features

- Dual-Side Cooling
- Integrated Chip Level Temperature and Current Sensor
- $T_{vi max} = 175$ °C for Continuous Operation
- Ultra-low stray inductance
- Low V_{CESAT} and Switching Losses
- Automotive Grade FS4 & Fast Diode Chip Technologies
 4.2 kV Isolated DBC Substant
- 4.2 kV Isolated DBC Substrate
- AEC Qualified and PPAP Capable
- This Device is Pb-Free and is RoHS Compliant

Typical Applications

- Hybrid and Electric Vehicle Traction Inverter
- High Power DC-DC Converter



ORDERING INFORMATION

See detailed ordering and shipping information on page 5 of this data sheet.

PIN DESCRIPTION

Pin #	Pin	Pin Function Description	Pin Arrangement
1	N	Low Side Emitter	2
2	Р	High Side Collector	9
3	H/S COLLECTOR SENSE	High Side Collector Sense	3 🔾
4	H/S CURRENT SENSE	High Side Current Sense	
5	H/S EMITTER SENSE	High Side Emitter Sense	6 0
6	H/S GATE	High Side Gate	4 0
7	H/S TEMP SENSE (CATHODE)	High Side Temp sense Diode Cathode	7 0
8	H/S TEMP SENSE (ANODE)	High Side Temp sense Diode Anode	8 0 9
9	~	Phase Output	15 0
10	L/S CURRENT SENSE	Low Side Current Sense	l
11	L/S EMITTER SENSE	Low Side Emitter Sense	12 0
12	L/S GATE	Low Side Gate	10 0
13	L/S TEMP SENSE (CATHODE)	Low Side Temp sense Diode Cathode	13 0
14	L/S TEMP SENSE (ANODE)	Low Side Temp sense Diode Anode	14 0
15	L/S COLLECTOR SENSE	Low Side Collector Sense	1

Materials

Flammability Information

MODULE CHARACTERISTICS

14	L/3 ILN	AF SENSE (ANODE)	Low Side Terrip Serise Diode Ariode					
15	L/S CC	OLLECTOR SENSE Low Side Collector Sense						
DBC S	Materials DBC Substrate: Al ₂ O ₃ isolated substrate, basic isolation, and copper on both sides Lead Frame: Copper with Tin electro-plating Flammability Information All materials present in the power module meet UL flammability rating class 94V-0 MODULE CHARACTERISTICS							
		sent in the power mod	dule meet UL					
flammab	flammability rating class 94V–0 MODULE CHARACTERISTICS							
Sy	ymbol	No No	Parameter Rating Unit					
	T _{vj}	Continuous Operating Jul	nction Temperature range -40 to 175 °C					
7	T _{STG}	Storage Temperature ran	ge -40 to 125 °C					
,	V _{ISO}	Isolation Voltage, DC, t =	1 s 4200 V					
Cre	eepage	Terminal to Terminal	6.2 mm					
Cle	earance	Terminal to Terminal	3.4 mm					
	CTI	Comparative tracking ind	ex >600 -					
			Min Typ Max					
I	L _{sCE}	Stray Inductance	8 nH					
Ro	CC'+EE'	Module lead resistance, to	terminals – chip $0.15 \hspace{1cm} \text{m}\Omega$					
	G	Module weight	75 g					
	М	M4 screws for module ter	rminals 2.2 Nm					

ABSOLUTE MAXIMUM RATINGS (T_{VJ} = 25°C, Unless Otherwise Specified)

Symbol	Parameter	Rating	Unit
GBT		•	
V _{CES}	Collector to Emitter Voltage	750	V
V_{GES}	Gate to Emitter Voltage	±20	V
I _{CN}	Implemented Collector Current	800	Α
I _{C nom}	Continuous DC Collector Current, Tv _{Jmax} = 175°C, T _F = 65°C, ref. heatsink	550 ⁽¹⁾	А
I _{CRM}	Pulsed Collector Current @ VGE = 15 V, t _p = 1 ms	1600	А
Diode		•	
V _{RRM}	Repetitive peak reverse voltage	750	V
I _{FN}	Implemented Forward Current	800	А
l _F	Continuous Forward Current, Tv _{Jmax} = 175°C, T _F = 65°C, ref. heatsink	420 (1)	A
I _{FRM}	Repetitive Peak Forward Current, t _p = 1 ms	1600	A
l ² t value	Surge current capability, $V_R = 0$ V, $t_p = 10$ ms, $Tv_J = 150^{\circ}C$ $T_{VJ} = 175^{\circ}C$	20000 18000	A ² s

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL CHARACTERISTICS (Verified by characterization, not by test.)

Symbol	Parameter Min	Тур	Max	Unit
IGBT.R _{th,J-C}	Effective Rth, Junction to Case (2)	0.05	0.07	°C/W
IGBT.R _{th,J-F}	Effective Rth, Junction to Fluid, λ _{TIM} = 6 W/m–K, F = 660 N 10 L/min, 65°C, 50/50 EGW, Ref. Heatsink	0.14		°C/W
Diode.R _{th,J-C}	Effective Rth, Junction to Case (2)	0.08	0.10	°C/W
Diode.R _{th,J-F}	Effective Rth, Junction to Fluid, $\lambda_{TIM}=6$ W/m–K, F = 660 N 10 L/min, 65°C, 50/50 EGW, Ref. Heatsink	0.21		°C/W

^{2.} For the measurement point of case temperature (Tc), DBC discoloration, picker circle print is allowed, please refer to the VE–Trac Dual assembly guide for additional details about acceptable DBC surface finish.

^{1.} Verified by characterization, not by test.

CHARACTERISTICS OF IGBT (Tvj = 25°C, Unless Otherwise Specified)

	Parameters	Conditions	Min	Тур	Max	Unit
V _{CESAT}	Collector to Emitter Saturation Voltage (Terminal)	V_{GE} = 15 V, I_{C} = 600 A, Tv_{J} = 25°C Tv_{J} = 150°C Tv_{J} = 175°C	-	1.30 1.42 1.45	1.55	V
		V_{GE} = 15 V, I_{C} = 800 A, Tv_{J} = 25°C Tv_{J} = 150°C Tv_{J} = 175°C		1.44 1.64 1.68		
I _{CES}	Collector to Emitter Leakage Current	$V_{GE} = 0$, $V_{CE} = 750 \text{ V}$ $Tv_J = 25^{\circ}\text{C}$ $Tv_J = 175^{\circ}\text{C}$	- -	- 8	1 -	mA mA
I _{GES}	Gate – Emitter Leakage Current	V _{CE} = 0, V _{GE} = ± 20 V	_	-	400	nA
V_{th}	Threshold Voltage	$V_{CE} = V_{GE}$, $I_C = 500 \text{ mA}$	4.6	5.5	6.2	V
Q_{G}	Total Gate Charge	$V_{GE=}$ –8 to 15 V, V_{CE} = 400 V	-	1.9	-	μC
R _{Gint}	Internal gate resistance		-	2	-16h	Ω
C _{ies}	Input Capacitance	V _{CE} = 30 V, V _{GE} = 0 V, f = 1 MHz		48	5	nF
C _{oes}	Output Capacitance	V _{CE} = 30 V, V _{GE} = 0 V, f = 1 MHz		1.37	-	nF
C _{res}	Reverse Transfer Capacitance	V _{CE} = 30 V, V _{GE} = 0 V, f = 1 MHz	NE	0.15	_	nF
T _{d.on}	Turn on delay, inductive load	I_C = 600 A, V_{CE} = 400 V Tv_J = 25°C V_{GE} = +15/-8 V Tv_J = 150°C Rg.on = 4.7 Ω Tv_J = 175°C	emi	253 283 287	-	ns
T _r	Rise time, inductive load	$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	MA	94 112 117	-	ns
T _{d.off}	Turn off delay, inductive load	$\begin{array}{cccccccccccccccccccccccccccccccccccc$	_	760 790 800	-	ns
T _f	Fall time, inductive load	$\begin{split} I_{C} &= 600 \text{ A}, V_{CE} = 400 \text{ V} & \text{Tv}_{J} = 25^{\circ}\text{C} \\ V_{GE} &= +15/-8 \text{ V} & \text{Tv}_{J} = 150^{\circ}\text{C} \\ \text{Rg.off} &= 15 \ \Omega & \text{Tv}_{J} = 175^{\circ}\text{C} \end{split}$	-	95 140 153	-	ns
E _{ON}	Turn-On Switching Loss (including diode reverse recovery loss)	I_C = 600 A, V_{CE} = 400 V, V_{GE} = +15/-8 V, I_S = 20 nH, Rg.on = 4,7 Ω di/dt (Tv _J = 25°C) = 5.13 A/ns di/dt (Tv _J = 175°C) = 4.11 A/ns	-		-	mJ
<	HIS DEPT	$Tv_J = 25^{\circ}C$ $Tv_J = 150^{\circ}C$ $Tv_J = 175^{\circ}C$		22.41 33.30 36.35		
E _{OFF}	Turn-Off Switching Loss	$\begin{array}{l} I_{C} = 600 \text{ A, V}_{CE} = 400 \text{ V, V}_{GE} = +15/-8 \text{ V,} \\ Ls = 20 \text{ nH, Rg.off} = 15 \Omega \\ dv/dt (Tv_{J} = 25^{\circ}C) = 2.81 \text{ V/ns} \\ dv/dt (Tv_{J} = 175^{\circ}C) = 2.11 \text{ V/ns} \\ \end{array}$			_	mJ
		$Tv_{J} = 25^{\circ}C$ $Tv_{J} = 150^{\circ}C$ $Tv_{J} = 175^{\circ}C$		27.22 37.19 39.09		
E _{SC}	Minimum Short Circuit Energy Withstand	V_{GE} = 15 V, V_{CC} = 400 V Tv_{J} = 25°C Tv_{J} = 175°C	5 7.5			J

CHARACTERISTICS OF INVERSE DIODE ($T_{VJ} = 25$ °C, Unless Otherwise Specified)

	Parameters	Conditions		Min	Тур	Max	Unit
V _F	Diode Forward Voltage (Terminal)	Tv.	J = 25°C J = 150°C J = 175°C		1.40 1.30 1.30	1.60	V
		Tv.	_J = 25°C _J = 150°C _J = 175°C		1.48 1.44 1.42		
E _{rr}	Reverse Recovery Energy	Tv	V, s (175°C) J = 25°C J = 150°C J = 175°C	-	4.09 10.93 11.92	-	mJ
Q _{RR}	Recovered Charge	Tv			18.70 44.48 48.40	3161	μС
Irr	Peak Reverse Recovery Current	Tv.	V, s (175°C) y = 25°C y = 150°C y = 175°C	NE	248 331 337	-	А

SENSOR CHARACTERISTICS (T_{VJ} = 25°C, Unless Otherwise Specified)

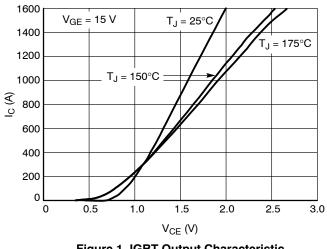
	Parameters	Conditions	Min	Тур	Max	Unit
T _{sense}	Temperature sense	I_F = 1 mA, Tv_J = -40° C Tv_J = 25° C Tv_J = 150° C Tv_J = 175° C	2.46 ⁽³⁾	2.96 2.54 1.76 1.61	2.60 ⁽³⁾	>
I _{sense}	Current sense	R_{shunt} = 5 Ω I_{C} = 1600 A I_{C} = 800 A I_{C} = 100 A		379 200 43.0		mV
_	HIS DE REPR	R_{shunt} = 20 Ω I_{C} = 1600 A I_{C} = 800 A I_{C} = 100 A		644 351 94.0		

^{3.} Measured at chip level

ORDERING INFORMATION

Part Number	Device Marking	Package	Shipping
NVG800A75L4DSC	N875DSC	AHPM15-CEA (Pb-Free)	6 Units / Tube

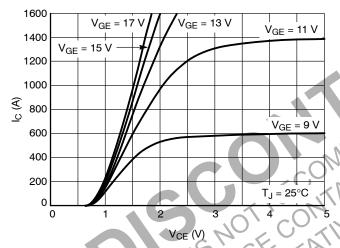
TYPICAL CHARACTERISTICS



1600 V_{CE} = 20 V 1400 1200 1000 800 600 $T_J = 150^{\circ}C$ 400 200 $T_J = 175^{\circ}C$ T_J = 25°C 10 12 V_{GE} (V)

Figure 1. IGBT Output Characteristic

Figure 2. IGBT Output Characteristic



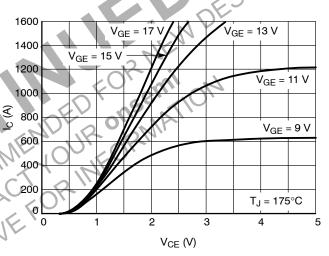
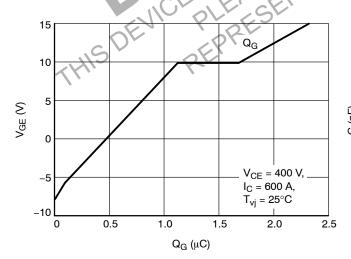


Figure 3. IGBT Output Characteristic

Figure 4. IGBT Output Characteristic



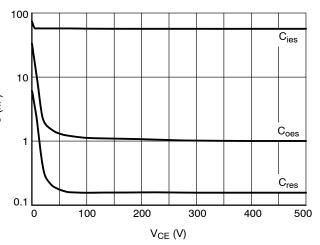
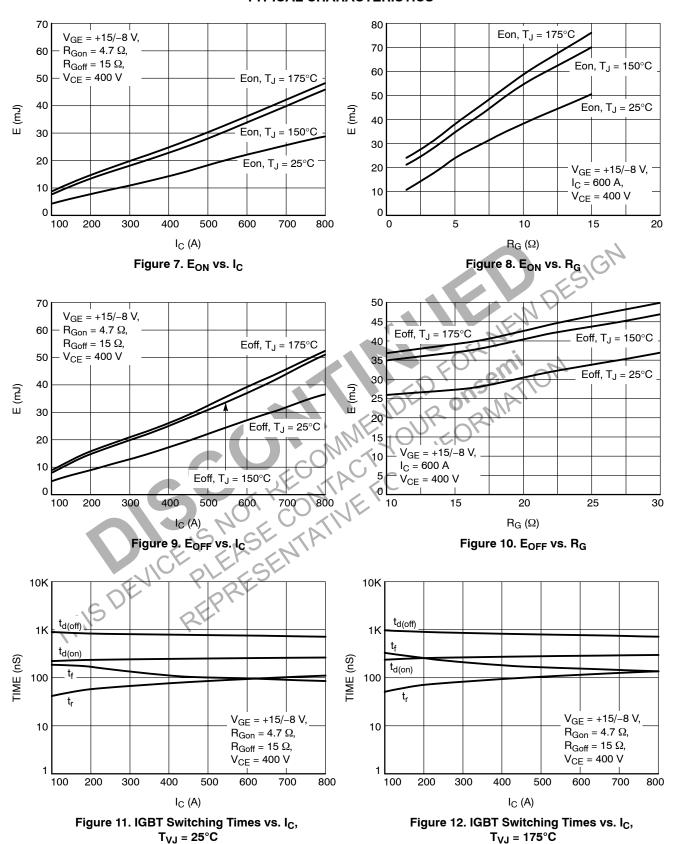


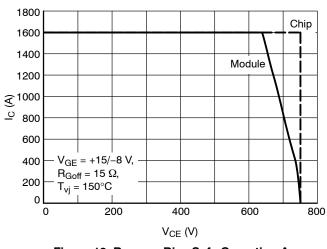
Figure 5. Gate Charge Characteristic

Figure 6. Capacitance Characteristic

TYPICAL CHARACTERISTICS



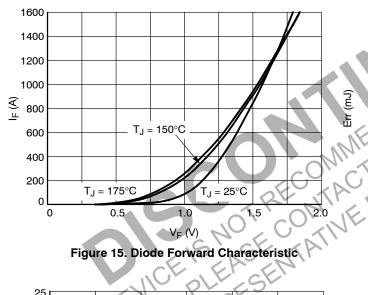
TYPICAL CHARACTERISTICS



10 L/Min, $T_f = 65^{\circ}C$, 50/50 EGW, Ref. Cooler Heatsink $Z_{th,j-f}$: IGBT 0.1 Zth (K/W) 0.01 2 3 R_{th} [K/W]: 0.019 0.089 0.005 0.028 τ_{th} [s]: 0.002 0.457 0.001 0.050 0.001 0.0001 0.001 0.01 0.1 10 TIME (s)

Figure 13. Reverse Bias Safe Operating Area

Figure 14. IGBT Transient Thermal Impedance



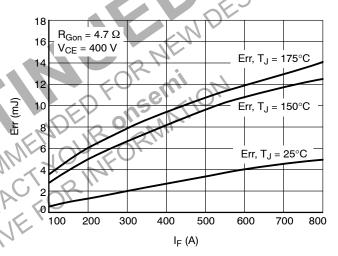
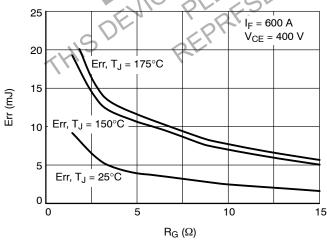


Figure 16. Diode Switching Losses vs. IF



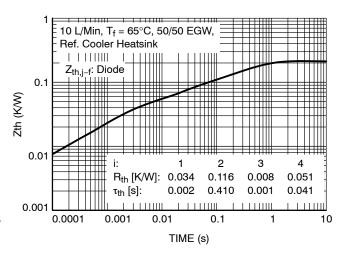
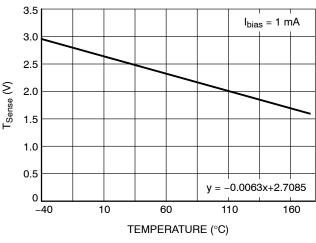


Figure 17. Diode Switching Losses vs. R_G

Figure 18. Diode Transient Thermal Impedance

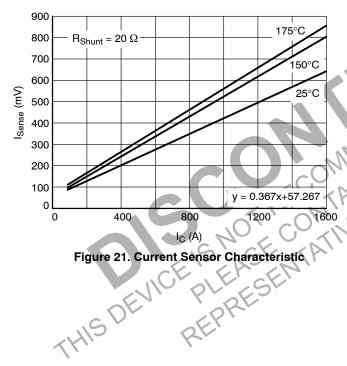
TYPICAL CHARACTERISTICS



500 175°C $R_{Shunt} = 5 \Omega$ 150°C 400 25°C I_{Sense} (mV) 300 200 100 y = 0.2243x + 20.1790 400 800 1600 1200 I_C (A)

Figure 19. Temperature Sensor Characteristic

Figure 20. Current Sensor Characteristic



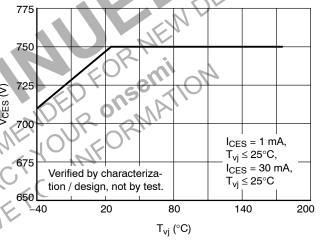


Figure 22. Maximum Allowed V_{CE}

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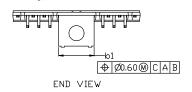
12X b2

É1

A

В

DATE 28 SEP 2022

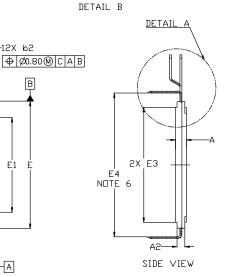


DETAIL B

-e1

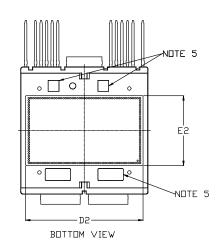


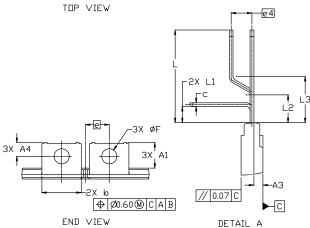




NOTES:

- DIMENSIONING AND TOLERANCING PER. ASME Y14.5M, 2009. CONTROLLING DIMENSION: MILLIMETERS
- DIMENSIONS D & E DO NOT INCLUDE MOLD
- PROTRUSIONS
 DIMENSIONS b,b1,b2 DO NOT INCLUDE
- DAMBAR REMAIN.
 MARKING AREA.
 E4 IS FROM INNER LEAD TIP TO INNER LEAD TIP DISTANCE.





	MILLIMETERS				
DIM	MIN.	N□M.	MAX.		
Α	4.65	4.70	4.75		
A1	10.75	11.05	11.35		
A2	3.20	3,40	3.60		
A3	1.60	1.95	2.30		
Α4	5.70	6.00	6.30		
b	16.90	17.00	17.10		
b1	15.20	15.30	15.40		
b2	0.90	1.00	1.10		
b3		0.50 REF	•		
C	0.70	0.80	0.90		
D	54.80	55.00	55,20		
D1	46.20	46.50	46.80		
D2	50.70	51.00	51.30		

	MILLIMETERS				
DIM	MIN.	N□M.	MAX.		
E	54.80	55.00	55.20		
E1	40.50	40.80	41.10		
E2	29.80	30.10	30.40		
E3	49.40	49.60	49.80		
E4	61.75	62.00	62.25		
е	10.30 BSC				
e1	11.45 BSC				
e2	i	2.40 BSC	;		
e3		4,20 BSC	;		
e4		4.50 BSC			
F	6,45	6.50	6,55		
L	19.60	20.00	20.40		
L1	3.10	3.50	3.90		
L2	5.70	6.00	6.30		
L3	9.70	10.00	10.30		
М	10° REF				

GENERIC MARKING DIAGRAM*



XXXXXXX NNNNNNN ZZZ = Assembly Lot Code

ΑT = Assembly & Test Site Code

= Year

WW = Work Week

XXXX = Specific Device Code NNN = Serial Number

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

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